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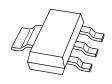
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Kind regards,

Team Nexperia



# PBSS9110Z 100 V, 1 A PNP low V<sub>CEsat</sub> (BISS) transistor Rev. 03 — 11 December 2009

**Product data sheet** 

#### 1. **Product profile**

## 1.1 General description

PNP low V<sub>CEsat</sub> Breakthrough In Small Signal (BISS) transistor in a SOT223 (SC-73) small Surface-Mounted Device (SMD) plastic package.

NPN complement: PBSS8110Z.

#### 1.2 Features

- Low collector-emitter saturation voltage V<sub>CEsat</sub>
- High collector current capability I<sub>C</sub> and I<sub>CM</sub>
- High collector current gain (h<sub>FE</sub>) at high I<sub>C</sub>
- High efficiency due to less heat generation
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

## 1.3 Applications

- High-voltage DC-to-DC conversion
- High-voltage MOSFET gate driving
- High-voltage motor control
- High-voltage power switches (e.g. motors, fans)
- Automotive applications

#### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{\text{CEO}}$	collector-emitter voltage	open base	-	-	-100	V
I <sub>C</sub>	collector current		-	-	-1	Α
I <sub>CM</sub>	peak collector current	$\begin{array}{l} \text{single pulse;} \\ t_p \leq 1 \text{ ms} \end{array}$	-	-	-3	Α
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_{C} = -1 \text{ A};$ $I_{B} = -100 \text{ mA}$	<u>[1]</u> -	170	320	mΩ

<sup>[1]</sup> Pulse test:  $t_p \le 300 \ \mu s; \ \delta \le 0.02.$ 



100 V, 1 A PNP low V<sub>CEsat</sub> (BISS) transistor

#### 2. **Pinning information**

Table 2. **Pinning** 

	9		
Pin	Description	Simplified outline	Symbol
1	base		
2	collector	4	2, 4
3	emitter		1 —
4	collector		3
			sym028

#### **Ordering information** 3.

**Ordering information** Table 3.

Type number	Package	Package		
	Name	Description	Version	
PBSS9110Z	SC-73	plastic surface-mounted package with increased heat sink; 4 leads	SOT223	

# **Marking**

Table 4. Marking codes

Type number	Marking code
PBSS9110Z	PB9110

# **Limiting values**

**Limiting values** Table 5.

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CBO}$	collector-base voltage	open emitter	-	-120	V
$V_{CEO}$	collector-emitter voltage	open base	-	-100	V
$V_{EBO}$	emitter-base voltage	open collector	-	-5	V
I <sub>C</sub>	collector current		-	-1	Α
I <sub>CM</sub>	peak collector current	$\begin{array}{l} \text{single pulse;} \\ t_p \leq 1 \text{ ms} \end{array}$	-	-3	Α
I <sub>B</sub>	base current		-	-0.3	Α
P <sub>tot</sub>	total power dissipation	$T_{amb} \le 25  ^{\circ}C$	[1] -	0.65	W
			[2] _	1	W
			[3] _	1.4	W

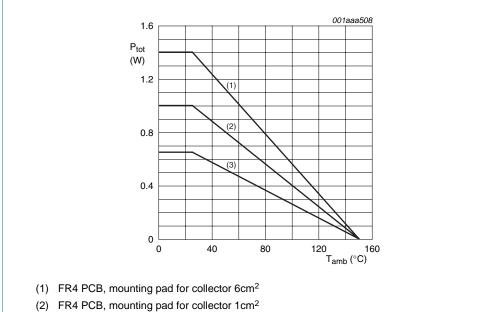
## 100 V, 1 A PNP low V<sub>CEsat</sub> (BISS) transistor

Table 5. Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
Tj	junction temperature		-	150	°C
T <sub>amb</sub>	ambient temperature		-65	+150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C

- Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1cm<sup>2</sup>.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6cm<sup>2</sup>.



**Power derating curves** Fig 1.

## Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from	in free air	<u>[1]</u> _	-	192	K/W
junction to ambient	junction to ambient		[2] _	-	125	K/W
			[3]	-	89	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	17	K/W

<sup>[1]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

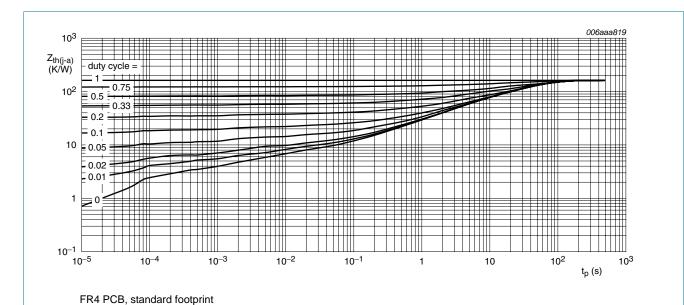
Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6cm<sup>2</sup>.

<sup>(3)</sup> FR4 PCB, standard footprint

Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1cm<sup>2</sup>.

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Transient thermal impedance from junction to ambient as a function of pulse duration; typical values Fig 2.

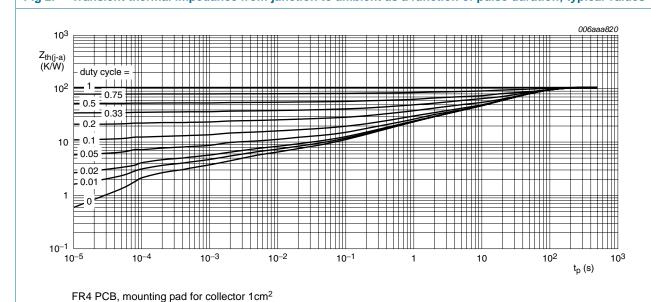
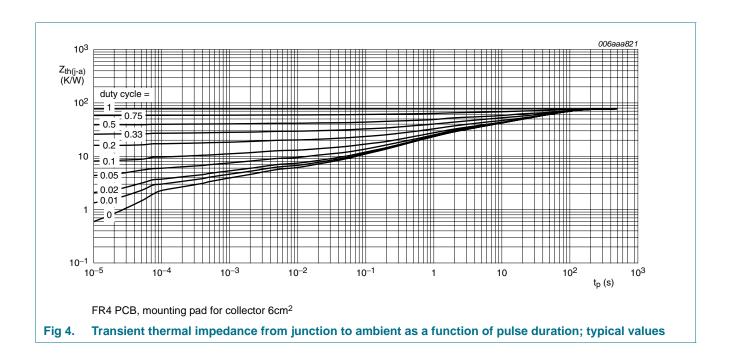


Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

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#### **7**. **Characteristics**

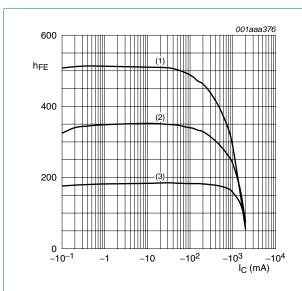
Characteristics

 $T_{amb} = 25$  °C unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I <sub>CBO</sub>	collector-base cut-off	$V_{CB} = -80 \text{ V}; I_E = 0 \text{ A}$		-	-	-100	nΑ
	current	$V_{CB} = -80 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 \text{ °C}$		-	-	-50	μА
I <sub>CES</sub>	collector-emitter cut-off current	$V_{CE} = -80 \text{ V};$ $V_{BE} = 0 \text{ V}$		-	-	-100	nA
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = -4 \text{ V}; I_C = 0 \text{ A}$		-	-	-100	nA
h <sub>FE</sub>	DC current gain	$V_{CE} = -5 \text{ V};$ $I_C = -1 \text{ mA}$		150	-	-	
		$V_{CE} = -5 \text{ V};$ $I_{C} = -250 \text{ mA}$		150	-	-	
		$V_{CE} = -5 \text{ V};$ $I_{C} = -0.5 \text{ A}$	<u>[1]</u>	150	-	450	
		$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ A}$	[1]	125	-	-	
V <sub>CEsat</sub>	collector-emitter saturation voltage	$I_{C} = -250 \text{ mA};$ $I_{B} = -25 \text{ mA}$		-	-	-120	mV
		$I_{C} = -500 \text{ mA};$ $I_{B} = -50 \text{ mA}$	[1]	-	-	-180	mV
	$I_C = -1 A;$ $I_B = -100 \text{ mA}$	[1]	-	-	-320	mV	
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_C = -1 A;$ $I_B = -100 \text{ mA}$	[1]	-	170	320	mΩ
$V_{BEsat}$	base-emitter saturation voltage	$I_C = -1 A;$ $I_B = -100 \text{ mA}$	[1]	-	-	-1.1	V
$V_{BEon}$	base-emitter turn-on voltage	$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ A}$	[1]	-	-	-1.0	V
t <sub>d</sub>	delay time	$V_{CC} = -10 \text{ V};$		-	20	-	ns
t <sub>r</sub>	rise time	$I_C = -0.5 \text{ A};$		-	60	-	ns
t <sub>on</sub>	turn-on time	$I_{Bon} = -0.025 \text{ A};$ $I_{Boff} = 0.025 \text{ A}$		-	80	-	ns
t <sub>s</sub>	storage time	_ Boil		-	290	-	ns
t <sub>f</sub>	fall time			-	120	-	ns
t <sub>off</sub>	turn-off time			-	410	-	ns
f <sub>T</sub>	transition frequency	$V_{CE} = -10 \text{ V};$ $I_{C} = -50 \text{ mA};$ $f = 100 \text{ MHz}$		100	-	-	MHz
C <sub>c</sub>	collector capacitance	$V_{CB} = -10 \text{ V};$ $I_E = i_e = 0 \text{ A};$ $f = 1 \text{ MHz}$		-	-	17	pF

<sup>[1]</sup> Pulse test:  $t_p \leq 300~\mu s;~\delta \leq 0.02.$ 

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$$V_{CE} = -10 \text{ V}$$

- (1)  $T_{amb} = 100 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \, ^{\circ}C$

Fig 5. DC current gain as a function of collector current; typical values

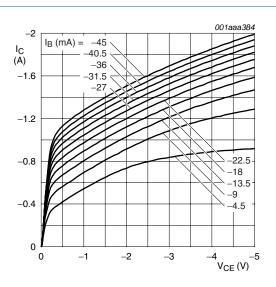
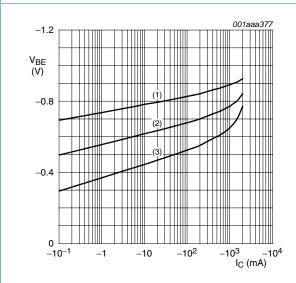


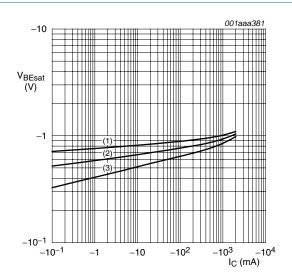
Fig 6. Collector current as a function of collector-emitter voltage; typical values





- (1)  $T_{amb} = -55 \,^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

Base-emitter voltage as a function of collector Fig 7. current; typical values

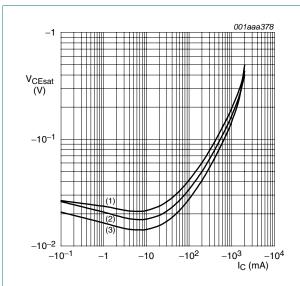


$$I_{\rm C}/I_{\rm B} = 10$$

- (1)  $T_{amb} = -55 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

Fig 8. Base-emitter saturation voltage as a function of collector current; typical values

100 V, 1 A PNP low V<sub>CEsat</sub> (BISS) transistor



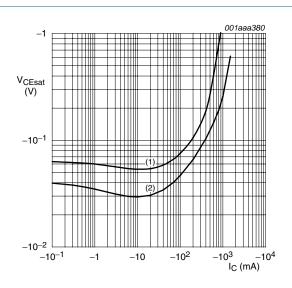
$$I_{\rm C}/I_{\rm B} = 10$$

(1) 
$$T_{amb} = 100 \, ^{\circ}C$$

(2) 
$$T_{amb} = 25 \, ^{\circ}C$$

(3)  $T_{amb} = -55 \, ^{\circ}C$ 

Collector-emitter saturation voltage as a Fig 9. function of collector current; typical values

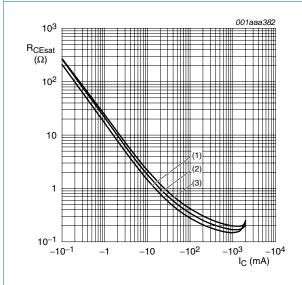


$$T_{amb} = 25 \, ^{\circ}C$$

(1) 
$$I_C/I_B = 50$$

(2)  $I_C/I_B = 20$ 

Fig 10. Collector-emitter saturation voltage as a function of collector current; typical values



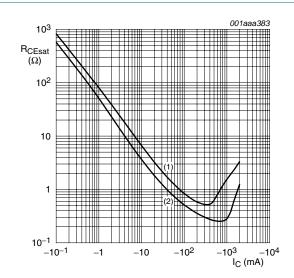
 $I_{\rm C}/I_{\rm B}=10$ 

(1)  $T_{amb} = -55 \,^{\circ}C$ 

(2)  $T_{amb} = 25 \, ^{\circ}C$ 

(3)  $T_{amb} = 100 \, ^{\circ}C$ 

Fig 11. Collector-emitter saturation resistance as a function of collector current; typical values



T<sub>amb</sub> = 25 °C

(1)  $I_C/I_B = 50$ 

(2)  $I_C/I_B = 20$ 

Fig 12. Collector-emitter saturation resistance as a function of collector current; typical values

#### 8. Test information

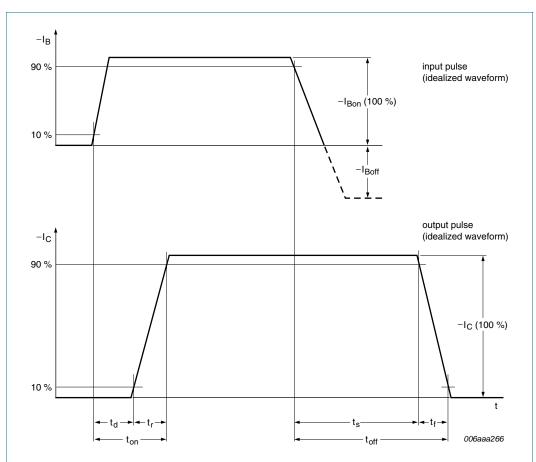
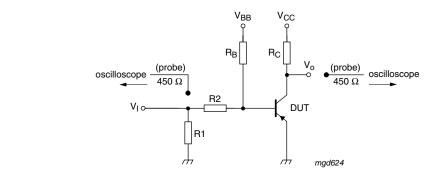


Fig 13. BISS transistor switching time definition



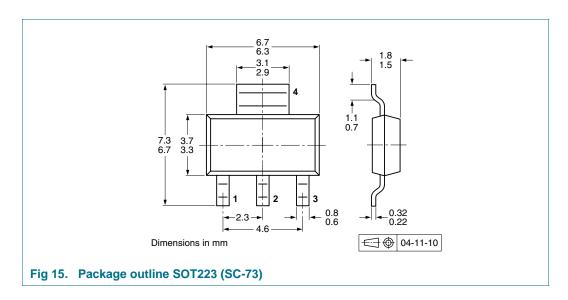
 $V_{CC} = -10 \text{ V}; I_C = -0.5 \text{ A}; I_{Bon} = -0.025 \text{ A}; I_{Boff} = 0.025 \text{ A}$ 

Fig 14. Test circuit for switching times

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100 V, 1 A PNP low V<sub>CEsat</sub> (BISS) transistor

# 9. Package outline



# 10. Packing information

Table 8. Packing methods

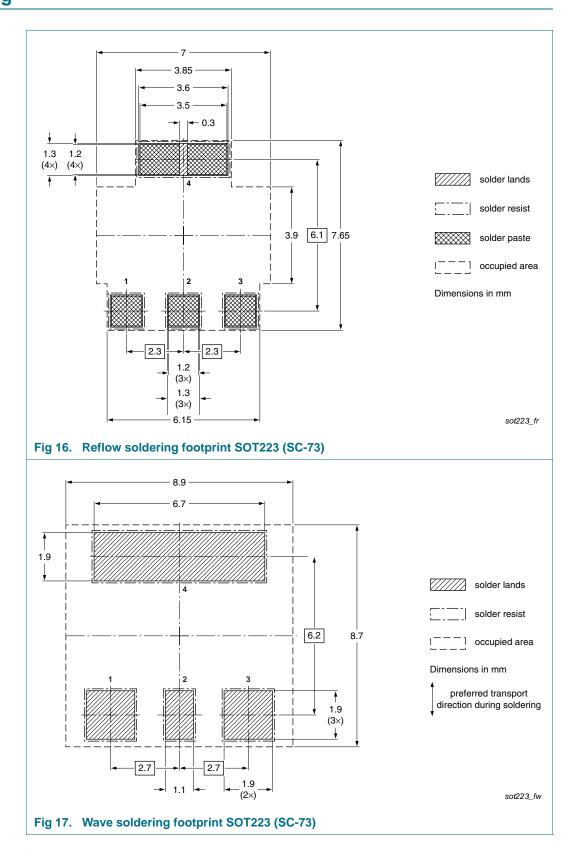
The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description	Packing q	uantity
			1000	4000
PBSS9110Z	SOT223	8 mm pitch, 12 mm tape and reel	-115	-135

[1] For further information and the availability of packing methods, see  $\underline{\text{Section 14}}$ .

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# 11. Soldering



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# 12. Revision history

#### Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS9110Z_3	20091211	Product data sheet	-	PBSS9110Z_2
Modifications:		eet was changed to reflect the was legal definitions and disclain		
	<ul><li>Figure 16 "F</li></ul>	Reflow soldering footprint SOT2	223 (SC-73)": update	ed
	<ul> <li>Figure 17 "V</li> </ul>	Vave soldering footprint SOT22	23 (SC-73)": updated	I
PBSS9110Z_2	20060724	Product data sheet	-	PBSS9110Z_1
PBSS9110Z_1	20040609	Product data sheet	-	-

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#### 13.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions".
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# 100 V, 1 A PNP low V<sub>CEsat</sub> (BISS) transistor

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